



FORM PTO-1449 (MODIFIED) PATENT & TRADEMARK OFFICE	ATTY. DOCKET NO. 36856.404	SERIAL NO. : 09/782,132
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT (USE SEVERAL SHEETS IF NECESSARY)	APPLICANT(S): Hisatake OKAMURA et al.	
	FILING DATE: February 13, 2001	GROUP: 2817

Reference Designation

U.S. Patents

Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
	AA				
	AB				
	AC				
	AD				
	AE				
	AF				
FOREIGN PATENT DOCUMENTS					
	Document Number	Date	Country	Class	Filing Date Subclass if appropriate
SS	AG 0 571 777 A1	12/1993	Europe		
SS	AH 0 509 636 A1	10/1992	Europe		
SS	AI 09162610	06/1997	Japan		
SS	AJ 0 646 981 A2	04/1995	Europe		
	AK				
	AL				
	AM				
	AN				
	A0				
OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)					
SS	AP Zhu L et al; New Planar Dual-Mode Filter Using Cross-Slotted Patch Resonator for Simultaneous Size and Loss Reduction; IEEE Transactions on Microwave Theory and Techniques, US, IEEE Inc. New York; vol 47, No. 5, May 1999, pp 650-654; XP000827467				
	AR				
	AS				
	AT				
EXAMINER	<i>Steph E. De</i>			DATE CONSIDERED	
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U.S. Patents

Examiner Initial	Document Number	Date	Name	Class	Filing Date Subclass if appropriate
	AA				
	AB				
	AC				
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FOREIGN PATENT DOCUMENTS					
Document Number	Date	Country	Class	Filing Date Subclass if appropriate	
SJ AG JP9162610	06/1997	Japan	///		
SJ AH JP6112701	04/1994	Japan	///		
SJ AI JP9139912 9139612	05/1997	Japan	///		
	AJ				
	AK				
	AL				
	AM				
	AN				
	A0				
OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)					
SJ	AP Abstract 1991 IEEE MTT-S Digest, PP 443-446, Miniature Dual Mode Microstrip Filters, J.A. Curtis and S.J. Fiedziuszko,				
	AR				
	AS				
	AT				
EXAMINER	Steph E. J.		DATE CONSIDERED	10-2-02	
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